Search Notes



Application/Control No.		
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10/084,372	L	

Applicant(s)/Patent under Reexamination		
LEE, KYUNG MEE		
Art Unit		

BRIAN P. YENKE

Examiner

2614

SEARCHED				
Class	Subclass	Date	Examiner	
348	714,716- 719	7/27/2005	ВРҮ	
	231.1, 553			
345	530, 535			
	541-547			
	555			
386	53,			
	111-112			
375	240, .01			
	240.24			
	240.26			
382	232/235			
725	134/142			
711	101/151			
	153/165			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
711/173	7/27/2005	BPY
V Kostak (382, 725)	7/26/2005	BPY
J Wu (382)		
T. Tran (386)		
R Elmore (711)		
J. Chung (725)		